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Research on Internet of Vehicles: Applications, Architectures, Enabling Technologies, Challenges and Opportunities

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Deadline for manuscript submissions:

closed (31 October 2024)

Message from the Guest Editors

This Special Issue welcomes contributions dealing with various technical aspects of IoV, including architectures, enabling technologies, and advanced applications, as well as other relevant topics in the field. Potential topics of interest include, but are not limited to, the following:

IoV architectures and protocols:

Cloud/edge computing for IoV;

Computation offloading and resource management for IoV; Advanced communication technologies for IoV;

Autonomous driving assisted by edge computing-enabled IoV:

AI/ML algorithms for IoV; Blockchain-based IoV:

Digital twin designs for IoV;

Advanced IoV applications;

Test-bed and simulation tools for IoV.











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Message from the Editor-in-Chief

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